Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/016,475	PROKSCH ET AL.
Examiner	Art Unit
Jay M. Patidar	2862

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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(INCLUDING S	CH NOTES EARCH STRATEGY	<u>') </u>
	DATE	EXMR
Search updated.	3/10/2005	JP
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